Keysight DSOX3PWR/DSOX4PWR/DSOX6PWR
Power Measurement Options
For InfiniiVision 3000, 4000 and 6000 X-Series Oscilloscopes

Data Sheet
Achieve Cost-Effective Analysis of Your Switch Mode and Linear Power Supply Characteristics

Today’s power supply designers are facing an increasing number of constraints in the development of high-efficiency, low-cost power supplies. Cost-effective solutions used to be the designer’s key target. Today, rising energy costs bring power supply efficiency to the forefront. Additionally, other constraints such as design compactness, migration to digital control, tighter voltage tolerances, and regulations for power quality and EMI force the need for quick and thorough power supply testing. Increasing design constraints translate into more time dedicated to power device measurement and analysis for today’s power supply designers.

In spite of the increasing analysis capability offered by many oscilloscopes over recent years, it is not uncommon to see designers perform measurements and analysis manually. These measurements typically take a considerable amount of time to capture, analyze and report.

### Table: Power Measurement Options

<table>
<thead>
<tr>
<th>Type of analysis</th>
<th>Measurement</th>
<th>DSOX3PWR on 3000A</th>
<th>DSOX3PWR on 3000T</th>
<th>DSOX4PWR</th>
<th>DSOX6PWR</th>
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<tr>
<td><strong>Input measurements</strong></td>
<td>Power quality:</td>
<td></td>
<td></td>
<td></td>
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<tr>
<td></td>
<td>– Real power</td>
<td>●</td>
<td>●</td>
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<td>●</td>
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<tr>
<td></td>
<td>– Apparent power</td>
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<td>●</td>
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<tr>
<td></td>
<td>– Reactive power</td>
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<tr>
<td></td>
<td>– Power factor</td>
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<td></td>
<td>– Crest factor (V&amp;I)</td>
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<tr>
<td></td>
<td>– Phase angle</td>
<td>●</td>
<td>●</td>
<td>●</td>
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<td></td>
<td>Current harmonics</td>
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<tr>
<td></td>
<td>Inrush current</td>
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<td><strong>Switching device measurements</strong></td>
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<tr>
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<td>Rds(on)</td>
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<td>Turn-on time</td>
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<td>Turn-off time</td>
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<td></td>
<td>Efficiency</td>
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<td>Transient response settling time</td>
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<td><strong>Frequency response measurements</strong></td>
<td>Power Supply Rejection Ratio (PSRR)</td>
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<td>Control loop response (Magnitude and phase plot)</td>
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<td><strong>Other</strong></td>
<td>Auto probe deskew</td>
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<td>Auto setup</td>
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</table>

Notes:
1. Based on IEC 61000-3-2 standard for class A, B, C, and D products. Tabular or bar chart display user-selectable display formats with automatic pass/fail color-coded indication along with total harmonic distortion (THD).
2. Power and energy losses based on V x I always, or Rds(on) or Vce(sat) during conduction phase only.
3. Duty cycle, pulse width, frequency, period, etc., versus time trend plot.
4. AC-to-DC, DC-to-AC, AC-to-AC, or DC-to-DC user-selectable efficiency measurements.
5. Utilizes scope’s built-in waveform generator. WaveGen option not required.
Power Device Analysis

The switching loss in a power supply determines its efficiency. You can easily characterize for instantaneous power loss and conduction power loss at the switching device over a designated switching cycle. To determine the efficiency of the power supply it is very important to measure the power loss during dynamic load changes.

By measuring the switching loss and conduction loss, you can characterize the instantaneous power dissipation in your switching power supply. Locating peak switching loss helps you analyze the reliability of the power supply. The di/dt and dv/dt represent the rate at which the current and voltage change at switching. This helps in analysis of reliable operation of the switching mode power supply.

Line Power Analysis

Power supply designers need to characterize the line power for power quality, harmonics and conducted emissions under different operating conditions of the power supply. Some of the implicit measurements are real power, apparent power, reactive power, power and crest factor and graphical display of harmonics with respect to standards such as IEC 61000-3-2 (Class A, B, C, D). By using a current probe and power measurement option, conducted power line harmonics can be measured. Also, line power analysis includes the inrush current measurement that shows the peak inrush current value when the power supply is first turned on.
Power Quality Analysis

The Power Quality analysis shows the quality of the AC input line. Some AC current may flow back into and back out of the load without delivering energy. This current, called reactive or harmonic current, gives rise to an “apparent” power which is larger than the actual power consumed. Power quality is gauged by these measurements: power factor, apparent power, true power, reactive power, crest factor, and phase angle of the current and voltage of the AC line.

Modulation Analysis

Modulation analysis allows designers to quickly see the on-time and off-time information of the PWM signal, which is difficult to visualize because the information bandwidth is much lower than the pulse switching frequency. Plotting the embedded variation of on time or off time in the PWM signal over a long period of time can reveal the control loop response of the feedback loop system. This measurement performs data trending on the switching variation of the acquired waveform in the following format.

- Frequency vs time
- Period vs time
- Duty cycle vs time
- Positive pulse width vs time
- Negative pulse width vs time

Output Analysis

Output analysis includes characterization of the ripple component (either power line or switching) in output DC voltage. Ripple is the residual AC component that is superimposed on the DC output of a power supply. Line frequency as well as switching frequency can contribute to ripple. This measurement analyzes the output voltage ripple and presents the peak-to-peak value as well as the frequency response of the captured signal.
Turn On/Off Time Analysis

This analysis measures the time taken to get to the steady output voltage of the power supply after the input voltage is applied (turn on time) and for the output voltage of the power supply to turn off after the input voltage is removed (turn off time).

Transient Response Analysis

Power supplies are subject to transient conditions, such as turn-on and turn-off transients, as well as sudden changes in output load and line input voltage. These conditions lead to one of the key specifications of the power supplies; load transient response. This analysis measures the load transient response of the DC output, namely the time taken for the DC output to stabilize during a load change.

Efficiency Analysis

Efficiency analysis tests the overall efficiency of the power supply by measuring the output power over the input power. This analysis requires a 4-channel oscilloscope because input voltage, input current, output voltage, and output current are measured.
PSRR (Power Supply Rejection Ratio)

Characterizing PSRR over frequency commonly involves the use of an expensive analyzer equipped with a DC bias port such as Keysight’s ENA network analyzers.

The DSOX3PWR/DSOX4PWR/DSOX6PWR option utilizes the InfiniiVision built-in WaveGen BNC output that generates a swept frequency, simplifying the test solution in one box and significantly reducing the cost.

The PSRR is defined as the ratio of the input ripple compared to the output ripple over a wide frequency range and is expressed in dB. The basic equation for PSRR is

\[
\text{PSRR} = 20 \log \left( \frac{\text{Ripple input (} V_{\text{in}} \text{)}}{\text{Ripple output (} V_{\text{out}} \text{)}} \right)
\]

Figure 11 shows an example of a PSRR measurement on a linear power supply using an InfiniiVision X-Series oscilloscope with the power option. In this measurement example, the scope measured a maximum rejection of 96 dB.

To learn more about PSRR measurements, refer to the application note listed at the end of this document.

Figure 10. The PSRR is defined as the ratio of the output ripple compared to the input ripple over a wide frequency range.

Figure 11. The PSRR is a measure of how well a circuit rejects ripple coming from the power supply input at various frequencies.
Control Loop Response (Bode)

A power supply is actually an amplifier with a negative feedback control loop as shown in Figure 12. This means that although you may think of a power supply as a DC amplifier, it actually amplifies AC to react to changes in output conditions, such as load changes.

Performing a Control Loop Response test requires that you inject an error signal over a band of frequencies into the feedback path of the control loop. The resistive-divider network of R1 and R2 is the feedback path in this diagram. To inject an error signal, a small resistor must be inserted into the feedback loop. The 5-Ω injection resistor shown in this schematic is insignificant in comparison to the series impedance of R1 and R2. So you might consider designing in this low-value injection resistor (Rinj) permanently for test purposes. An injection transformer, such as Picotest’s J2101A, is also required so that the AC disturbance signal is isolated and doesn’t induce any DC bias.

The measurement system, in this case an InfiniiVision X-Series oscilloscope with its built-in WaveGen function/AWG generator, measures AC voltage levels at the top of the feedback network (Vin) as well as at the regulated DC output (Vout) of the power supply. The scope then computes gain as 20Log(Vout/Vin) at each frequency within the swept band. Also measured at the same time is the phase difference between Vin and Vout.

Figure 13 shows the results of a Control Loop Response gain and phase plot using an InfiniiVision X-Series oscilloscope. This test was performed using a swept frequency from 100 Hz up to 20 MHz. At the completion of the swept measurement, the scope automatically measured the phase margin at the 0 dB cross-over frequency, and also measured the gain margin at the 0 degree cross-over frequency.

To learn more about Control Loop Response measurements, refer to the application note listed at the end of this document.
Probe Deskewing With the U1880A Deskew Fixture

Timing delay errors between voltage and current probes may have a significant impact on power measurements as each specific voltage and current probes have different propagation delays. To make accurate power measurements and calculations, it is extremely important to null out the time delay between the voltage and current probes using a procedure known as “deskewing.” This step is critically important since a small offset in the timing of the voltage and current traces can cause a large error in the instantaneous power reading. By performing probe deskew before making power measurements, you can ensure the most accurate measurement.

The Keysight U1880A deskew fixture allows you to quickly deskew your voltage and current probes, enabling accurate and precise measurements of power supply efficiency. The U1880A deskew fixture generates a built-in voltage and current test signal and allows you to probe the same electrical point with a variety of voltage and current probes. With only a single click in one of the power measurements setup, deskewing is automatically performed and the deskew factors are saved in the power measurement application, so the next time when you launch the power measurement application, you can use the saved deskew values or perform the deskewing again.

Figure 14. To make accurate power measurements and calculations, it is extremely important to null out the time delay between your voltage and current probes.

Figure 15. The Keysight U1880A deskew fixture allows you to quickly deskew your voltage and current probes, enabling accurate and precise measurements of power supply efficiency.
Ordering Information

<table>
<thead>
<tr>
<th>Product number</th>
<th>Description</th>
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<tbody>
<tr>
<td>DSOX3PWR</td>
<td>Power Measurement software integrated into the 3000 X-Series (also includes the U1881A PC-based Power Measurement and Analysis software license)</td>
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<tr>
<td>DSOX4PWR</td>
<td>Power Measurement software integrated into the 4000 X-Series (also includes the U1881A PC-based Power Measurement and Analysis software license)</td>
</tr>
<tr>
<td>DSOX6PWR</td>
<td>Power Measurement software integrated into the 6000 X-Series (also includes the U1881A PC-based Power Measurement and Analysis software license)</td>
</tr>
<tr>
<td>U1880A</td>
<td>Deskew fixture for voltage and current probe deskewing</td>
</tr>
</tbody>
</table>

1. To learn more about the U1881A PC-based power measurement application for InfiniiVision oscilloscopes, refer to the U1881A data sheet with Keysight literature number 5989-7835EN.

Recommended Probes and Accessories

For more information about Keysight’s scope probes and accessories, visit www.keysight.com/find/probes.

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<tr>
<th>Recommended probes</th>
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<tbody>
<tr>
<td>AC/DC current probes (one or more of these Keysight current probes)</td>
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<td>1147B</td>
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<td>Differential probes</td>
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<td>N2805A</td>
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<td>Passive probe (for measuring output noise and PSRR)</td>
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<td>N2870A</td>
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<td>N2804A</td>
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Related Literature

<table>
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<tr>
<th>Publication title</th>
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<tr>
<td>Switch Mode Power Supply Measurements - Application Note</td>
<td>5991-1117EN</td>
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<tr>
<td>Power Supply Control Loop Response (Bode Plot) Measurements - Application Note</td>
<td>5992-0593EN</td>
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<tr>
<td>Power Supply Rejection Ratio (PSRR) Measurements - Application Note</td>
<td>5992-0594EN</td>
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</table>
Keysight Oscilloscopes

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Opt. 3 (IT)
United Kingdom 0800 0260637

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Published in USA, December 2, 2017
5990-8869EN
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